

Philips

Diode BYG85B

Datasheet

Silicon Diode

BYG85B

100V/980mA

DATASHEET

OEM – Philips

Source: Philips Databook 1999

Fast soft-recovery rectifier**BYG85B****FEATURES**

- Glass passivated
- High maximum operating temperature
- Low leakage current
- Excellent stability
- UL 94V-0 classified plastic package
- Shipped in 12 mm embossed tape.

DESCRIPTION

DO-214AC surface mountable package with glass passivated chip.

The well-defined void-free case is of a transfer-moulded thermo-setting plastic.

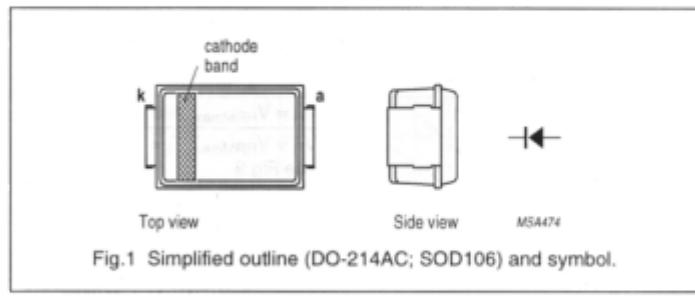


Fig.1 Simplified outline (DO-214AC; SOD106) and symbol.

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_{RRM}	repetitive peak reverse voltage		–	100	V
V_R	continuous reverse voltage		–	100	V
$I_{F(AV)}$	average forward current	$T_{tp} = 100^\circ\text{C}$; averaged over any 20 ms period; see Figs 2 and 7	–	2.5	A
$I_{F(AV)}$	average forward current	$T_{amb} = 60^\circ\text{C}$; Al_2O_3 PCB mounting (see Fig.11); averaged over any 20 ms period; see Fig.3	–	1.3	A
$I_{F(AV)}$	average forward current	$T_{amb} = 60^\circ\text{C}$; epoxy PCB mounting (see Fig.11); averaged over any 20 ms period; see Fig.3	–	0.98	A
I_{FRM}	repetitive peak forward current	$T_{tp} = 100^\circ\text{C}$; see Fig.3	–	23	A
I_{FRM}	repetitive peak forward current	$T_{amb} = 60^\circ\text{C}$; Al_2O_3 PCB mounting; see Fig.5	–	12	A
I_{FRM}	repetitive peak forward current	$T_{amb} = 60^\circ\text{C}$; epoxy PCB mounting; see Fig.6	–	8.5	A
I_{FSM}	non-repetitive peak forward current	$t = 10\text{ ms half sine wave}$; $T_j = T_{j\max}$ prior to surge; $V_R = V_{RRM\max}$	–	35	A
T_{stg}	storage temperature		-65	+175	°C
T_j	junction temperature		-65	+175	°C

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BYG85B

ELECTRICAL CHARACTERISTICS

 $T_j = 25^\circ\text{C}$ unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V_F	forward voltage	$I_F = 2 \text{ A}; T_j = T_{j\max}; \text{ see Fig.8}$	—	—	0.78	V
		$I_F = 2 \text{ A}; \text{ see Fig.8}$	—	—	0.98	V
$V_{(BR)R}$	reverse avalanche breakdown voltage	$I_R = 0.1 \text{ mA}$	120	—	—	V _{(BR)R}
I_R	reverse current	$V_R = V_{RRM\max}; \text{ see Fig.9}$	—	—	5	μA
		$V_R = V_{RRM\max}; T_j = 165^\circ\text{C}; \text{ see Fig.9}$	—	—	150	μA
t_{rr}	reverse recovery time	when switched from $I_F = 0.5 \text{ A}$ to $I_R = 1 \text{ A}$; measured at $I_R = 0.25 \text{ A}$; see Fig.13	—	—	12.5	ns
C_d	diode capacitance	$f = 1 \text{ MHz}; V_R = 0; \text{ see Fig.10}$	—	110	—	pF
$\left \frac{dI_R}{dt} \right $	maximum slope of reverse recovery current	when switched from $I_F = 1 \text{ A}$ to $V_R \geq 30 \text{ V}$ and $dI_F/dt = -1 \text{ A}/\mu\text{s}$; see Fig.12	—	—	2	$\text{A}/\mu\text{s}$

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
$R_{th j\text{-tp}}$	thermal resistance from junction to tie-point	—	25	K/W
$R_{th j\text{-a}}$	thermal resistance from junction to ambient	note 1	100	K/W
		note 2	150	K/W

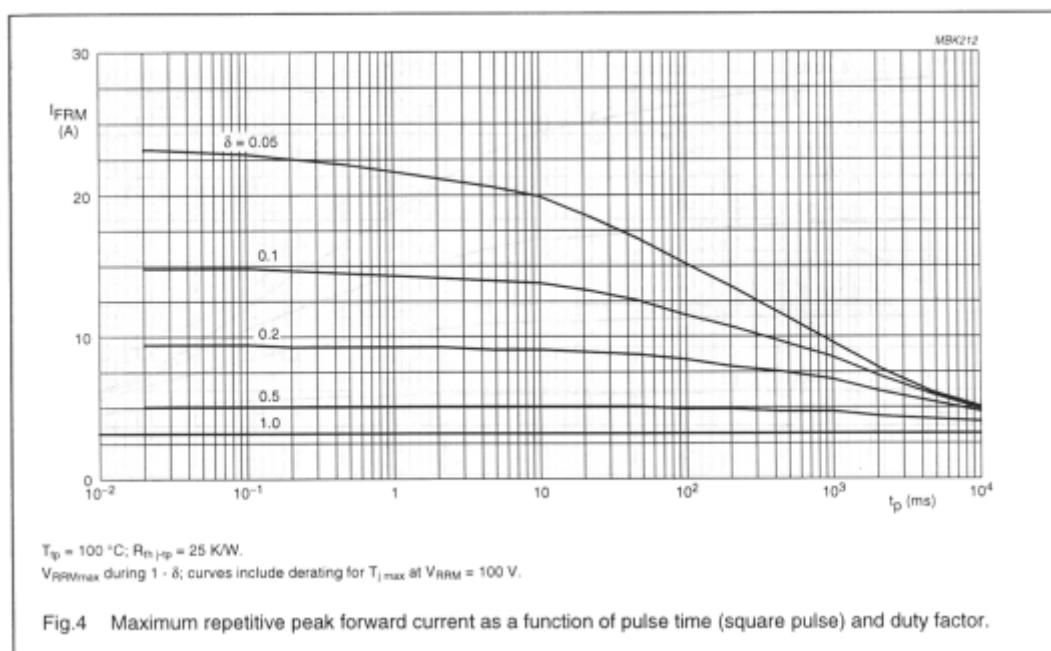
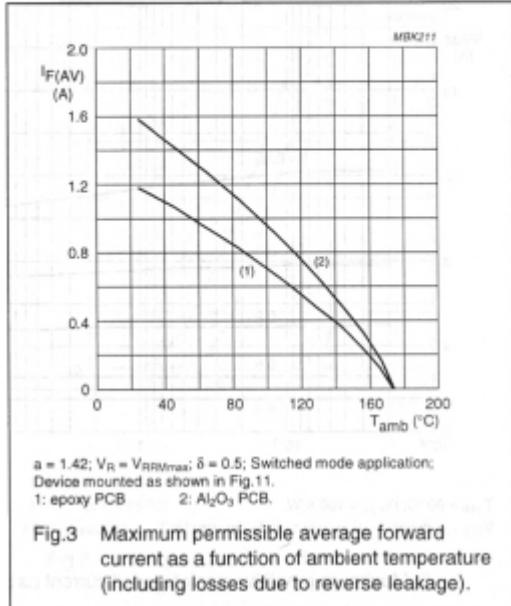
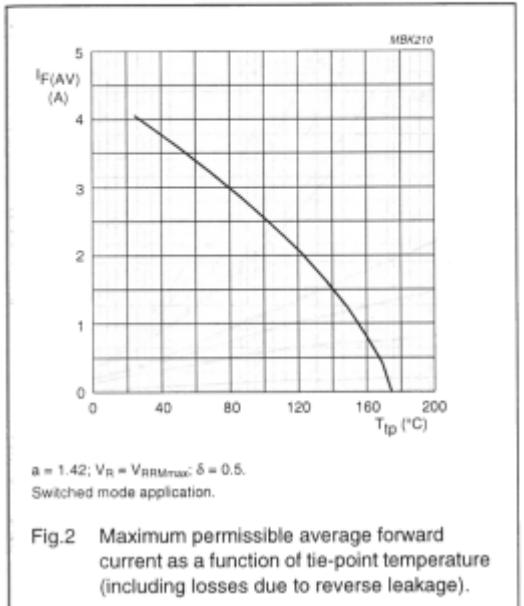
Notes

1. Device mounted on Al_2O_3 printed-circuit board, 0.7 mm thick; thickness of copper $\geq 35 \mu\text{m}$, see Fig.11.
2. Device mounted on epoxy-glass printed-circuit board, 1.5 mm thick; thickness of copper $\geq 40 \mu\text{m}$, see Fig.11.
For more information please refer to the 'General Part of associated Handbook'.

Fast soft-recovery rectifier

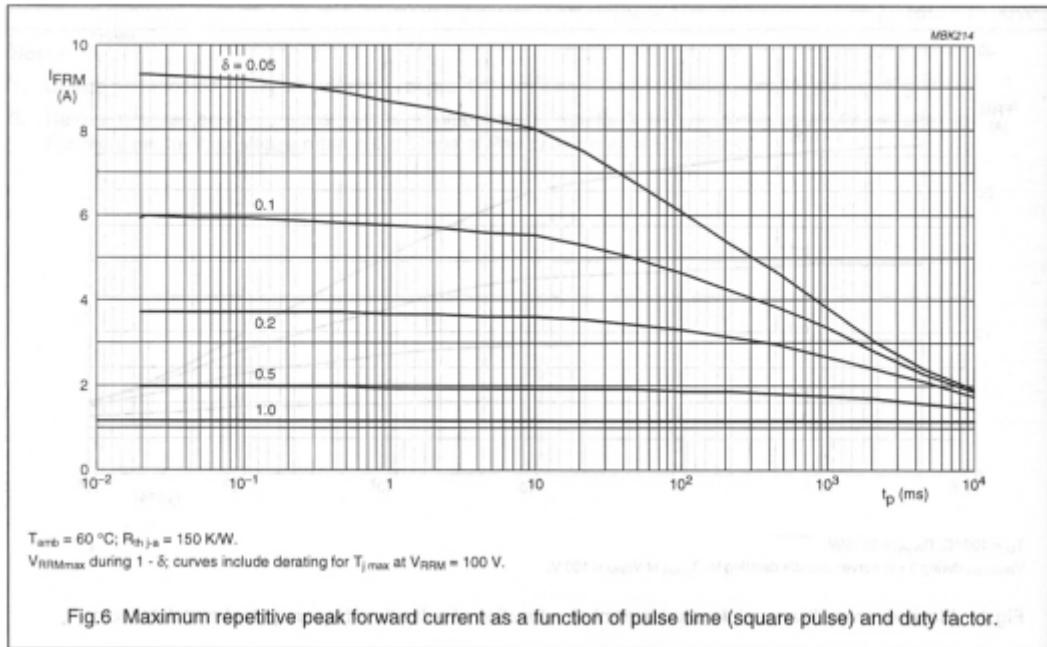
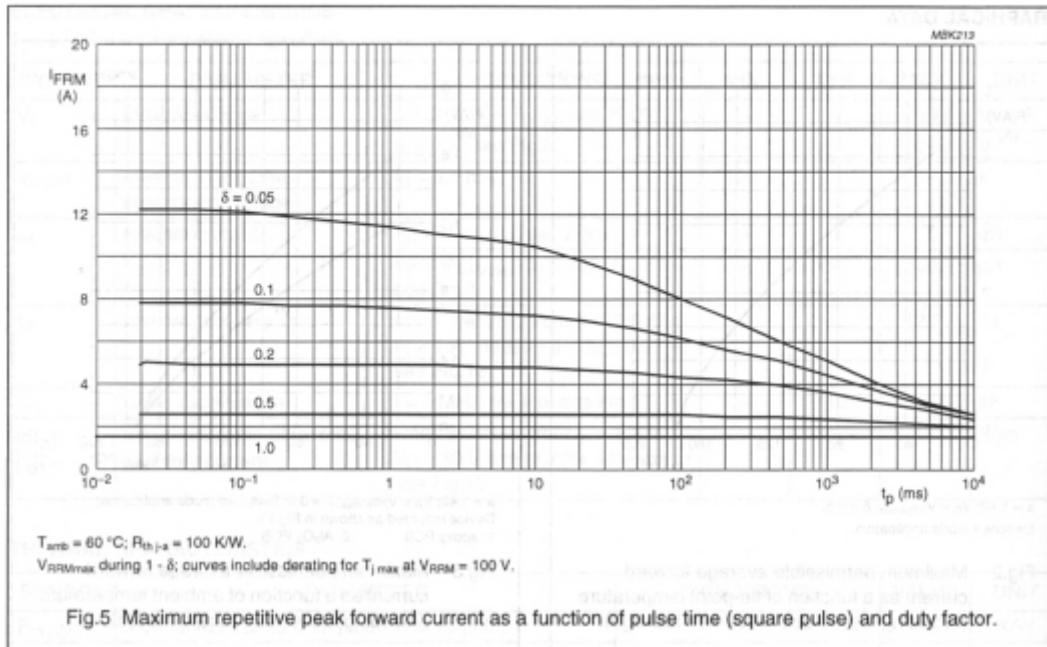
BYG85B

GRAPHICAL DATA



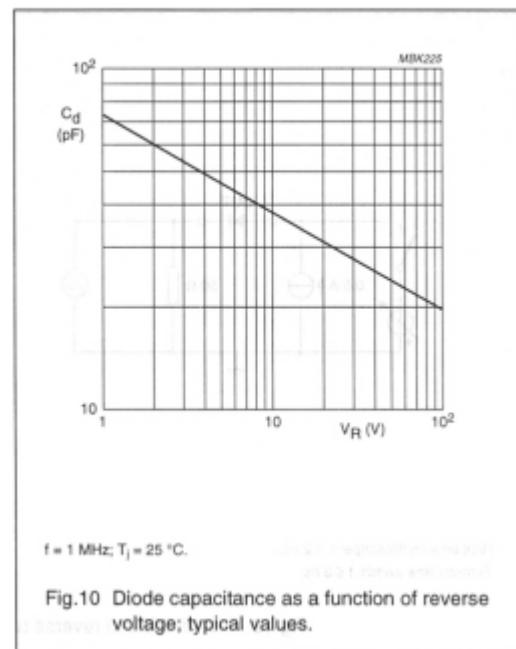
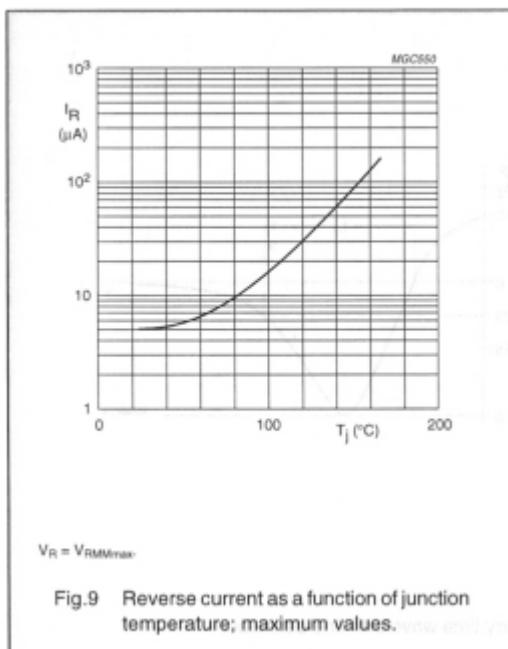
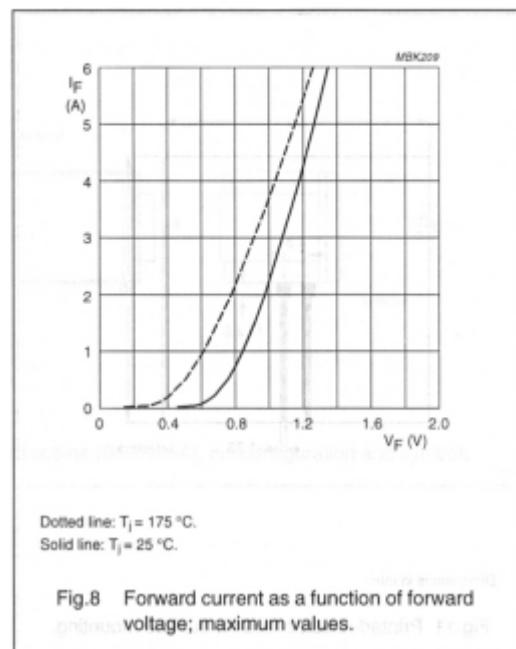
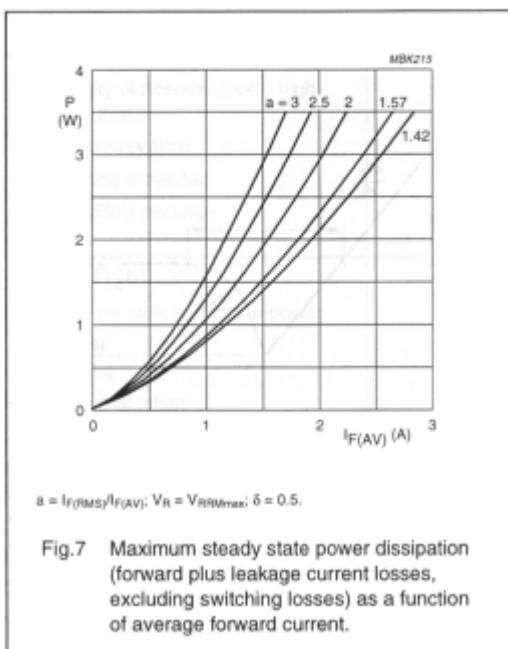
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BYG85B



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Technical Information BYG85B

